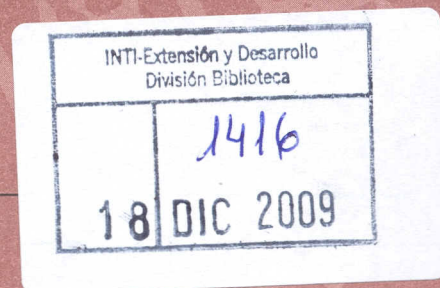


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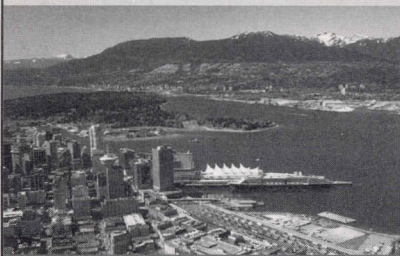
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[*J. Electrochem. Soc.*, 156, A833 (2009)]

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